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Examiner

Jianchun Qin

10/645,850

Applicant(s)/Patent under Reexamination
YAMADA ET AL.

Art Unit

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	SEARCHED		
Class	Subclass	Date	Examiner
84	601,602	6/14/2005	159
	604-609	1	
711	100		
365	203.01		
369	30.7		
	30.04	1	
	30.26	6/15/2005	TO
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

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